

## Precise roughness measurement Surface texture parameters in practice

## Surface texture measurement with Jenoptik

Surface texture is very important where it has a direct influence on the quality of the part. Therefore, it has to be defined as precisely as possible with the help of standardized surface texture parameters.

This leaflet gives you an overview of the most important definitions, standards, and parameters of surface texture measurement.

We manufacture a wide range of roughness measuring systems providing you with a large variety of evaluation possibilities – in the measuring lab as well as on the production line.

One particularly important aspect is the continuous monitoring of the roughness measuring systems for optimum accuracy. Our DAkkS-DKD calibration laboratory can calibrate your standards based on different surface texture parameters. For parameters not requiring accreditation, we offer an in-house calibration certificate.

## Division of a surface

Unfiltered P-profile

Filtered W-profile Wt Filtered R-profile In

## Surface profiles – total height of the profile

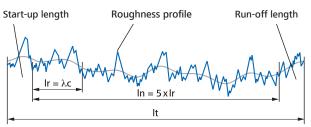
Surface profile is measured two-dimensionally using the tracing system.

The unfiltered primary profile (P-profile) is the actual measured surface profile. Filtering it in accordance with ISO 11562/ISO 16610-21 produces the waviness profile (W-profile) and the roughness profile (R-profile). The variable for determining the limit between waviness and roughness is the cut-off  $\lambda$ c.

Following ISO 4287, all parameter definitions are valid for both the roughness profile as well as for the primary and waviness profiles. The profile type is identified by the capital letters P, R or W.

The total height Pt, Wt or Rt of the respective profile type is the maximum height between the highest peak and the deepest valley of the evaluation length profile.

## Evaluation lengths – cut-off



The traverse length (lt) is the total length of the probe movement during the scanning process. It must be greater than the evaluation length In in order to be able to form the roughness profile with the profile filter.

With the exception of Rt, Rmr(c) and RPc, the roughness parameters are defined within an evaluation length ln, which is determined using an average of five sampling lengths lr.

The sampling length Ir corresponds to the cut-off  $\lambda c$ .

## Selection of the cut-off (profile filter) according to ISO

The cut-off is selected depending on the workpiece surface either according to the valley spacing, or the expected roughness values. At the same time the total evaluation length and

Periodic profiles			Measurement conditions			
e.g. turning, mil		lr In It λc λs r <sub>tip</sub> ΔΧ	evalu trave cut-o short stylus	ling length ation length rse length ff wave profile tip radius zation distan	filter	
RSm (mm)		λc = l	r (mm)	ln (mm)	lt (mm)	
RSm (mm)	0.04	$\frac{\lambda c = h}{0.08}$	5			
	0.04		5	In (mm)	lt (mm)	
> 0.013		0.08	5	In (mm)	<b>It (mm)</b> 0.48	
> 0.013	0.13	→ 0.08 → 0.25	5	In (mm) 0.4 1.25	It (mm)   0.48   1.5	

#### Application example

In a periodic profile the mean width of the profile elements RSm is used. With an RSm between 0.4 and 1.3 mm the following measuring conditions result:  $\lambda c = 2.5 \text{ mm} / \text{ln} = 12.5 \text{ mm} / \text{lt} = 15 \text{ mm} / r_{vp} = 5 \text{ µm} / \lambda s = 8 \text{ µm}.$ 

\* At Rz  $\leq$  2 µm the stylus tip radius is 2 µm, at Rz > 2 µm it is 5 µm. The distance between two measuring points is  $\leq$  0.5 µm.

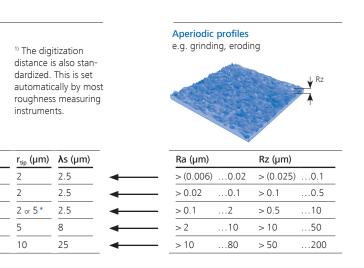
## Measurement conditions for Motif parameters according

A* (mm)	B* (mm)	Traverse length (mm)
0.02	0.1	0.64
0.1	0.5	3.2
0.5	2.5	16
2.5	12.5	80

\* If not otherwise specified, the default values are A = 0.5 mm and B = 2.5 mm, respectively. The defined limit A

## 4288:1998 and ISO 3274:1998

the corresponding traverse length are defined according to standards. Deviations are necessary if the workpiece does not allow the required traverse length. See drawing entries.



#### Shortened standard evaluation length

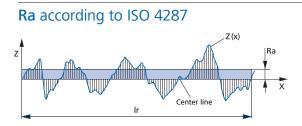
If the actual possible traverse length on the workpiece surface is not enough for It, the number of sampling lengths is reduced accordingly and specified in the drawing.

If the actually available traverse length is less than a sampling length, the total height of profile Pt of the primary profile is evaluated instead of Rt or Rz.

## to ISO 12085

Evaluation length (mm)	<b>λ</b> s (μm)	Max. stylus tip radius (µm)
0.64	2.5	2 ± 0,5
3.2	2.5	2 ± 0,5
16	8	5 ± 1
80	25	10 ± 2

determines in this case that the measured AR parameters are always smaller than 0.5 mm.

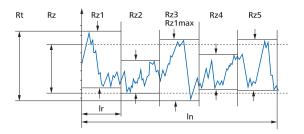


#### Ra – arithmetical mean deviation

Ra is the arithmetic mean roughness value from the amounts of all profile values. Ra does not differentiate between peaks and valleys and has therefore a relatively weak information character.

$$Ra = \frac{1}{lr} \int_{0}^{lr} |Z(x)| \, dx$$

## Rz, Rz1max, Rt according to ISO 428

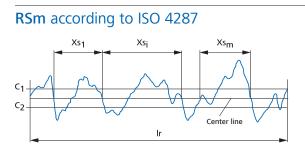


Rz – maximum height of profile Average value of the five Rz values.

#### Rz1max – maximum height of profile (ISO 4287:1997) Greatest Rz value from the five sampling lengths lr.

#### Rt – total height of profile

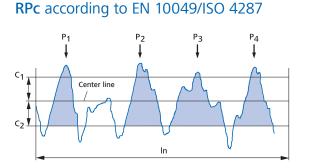
Rt is the distance between the highest peak and the deepest valley of the profile of the total evaluation length In.



#### RSm – mean width of the profile elements

RSm is the arithmetic mean value of the width of the roughness profile elements within the sampling length and requires the definition of height discriminations (c1, c2) matching the function of the surface. If not specified otherwise, the sum of the height discriminations should add up to 10 % of Rz.

 $RSm = \frac{1}{m}\sum_{i=1}^m Xs_i$ 



#### RPc – standardized number of peaks

RPc corresponds to the number of local peaks, which successively exceed an upper section line c1 and a lower section line c2. The number of peaks is related to a length of 10 mm irrespective of the evaluation length selected.

## We assist you worldwide.

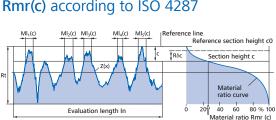
Our qualified employees are available to assist you across the globe. We have subsidiaries and distribution partners in key industrial nations, meaning that we are always close by to offer you optimum support as a reliable partner.





Visit us on YouTube.

JENOPTIK Industrial Metrology Germany GmbH | Drachenloch 5 78052 Villingen-Schwenningen | Germany | P +49 7721 6813-0 F +49 7721 6813-444 | metrology@jenoptik.com | www.jenoptik.com/metrology



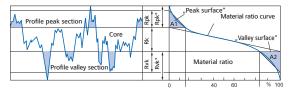
## Rmr(c) according to ISO 4287

#### Rmr(c) – material ratio of the profile

Rmr indicates what ratio the totaled length in the material has assumed relative to the evaluation length (in %). The comparison is made in the specified section height c and the total evaluation length In. The material ratio curve indicates the material ratio as a function of the section height.

$$Rmr(c) = \frac{100}{ln} \sum_{i=1}^{n} MI_i(c) = \frac{MI(c)}{ln} [\%]$$

## Rk, Rpk, Rvk, Mr1, Mr2 according to ISO 13565-2



Rk – core roughness depth

Depth of the roughness core profile.

#### Rpk – reduced peak height

Mean height of the peaks protruding from the roughness profile.

#### Rpk\* - highest profile peak height (not ISO 13565-2)

#### Rvk – reduced vallev depth

Mean depth of the valleys reaching into the material from the core.

#### Rvk\* – deepest profile valley depth (not ISO 13565-2)

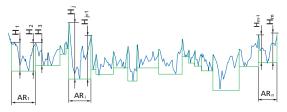
#### Mr1, Mr2 – material ratio

Smallest (Mr1) and greatest (Mr2) material ratio (in %) at the limits of the roughness core area.

## Motif standard according to ISO 12085

The principle of the Motif standard consists of looking for local peaks and valleys in the primary profile, and associating one valley with the closest preceding and following peaks in order to create a Motif. Several iterative combinations of two Motifs each assure that the most important Motifs, the width of which fall below the limit A, are considered. If not otherwise specified, the default value is A = 0.5 mm (see measurement conditions page 4/5).

The limit A has a similar function as the cut-off in the Gaussian filtering. The 16 % rule generally applies.



## The most important Motif parameters:

#### R – Mean depth of roughness Motifs

R is the arithmetic mean value of the depths Hj of the roughness Motifs within the evaluation length.

#### AR – Mean spacing of roughness Motifs

AR is the arithmetic mean value of the lengths ARi of the roughness Motifs within the evaluation length.

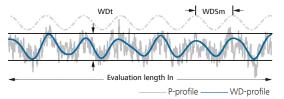
#### Rx – Maximum depth of profile irregularity

The deepest depth Hj within the evaluation length.

## WDSm, WDt, WDc – Dominant waviness according to VDA 2007

The primary profile is checked for none, one or two dominant wavinesses. Narrow band filtering of the primary profile with the waviness creates the WD-profile that is used for calculating the parameters. The evaluation length In is chosen either according to ISO 4288 (as for surface roughness measurements) or on the basis of the drawing entry.

Period lengths are checked for dominant wavinesses in the range of 0.02 mm  $\leq$  WDSm  $\leq$  ln/5. To catch dominant wavinesses at WDSm > ln/5, it is necessary to enlarge the evaluation length.



## WDSm

Mean horizontal value of the profile elements, calculated from the amplitude spectrum (mean periodic length of the dominant waviness).

## WDt

Vertical difference between the highest and the deepest point of the WD-profile within the evaluation length.



## WDc

Mean value of the peaks of the profile elements within the evaluation length. 1 N

$$WDc = \frac{1}{N} \sum_{i=1}^{N} \Delta z_i$$

## Evaluation of measurement results

According to ISO 4288 the surface measurement should be made where the highest values are to be expected (visual determination).

#### Maximum value rule

The surface is considered good when the measured values of a parameter do not exceed the fixed maximum value. In this case, the parameter is identified by the suffix "max", e.g. Rz1max.

#### 16% rule

If the suffix "max" is not specified, the 16% rule applies, which states that the surface is considered "good" if not more than 16% of the measured parameter values exceed the fixed maximum value. You will find further information about this rule in the standard ISO 4288:1997.

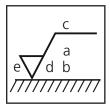
#### Special rule VDA

The 16% rule is not used. VDA 2006 assumes that the dispersion of the parameters is taken into account in the definition of the limit values. The maximum value rule applies generally even without the "max" index in the designation. The use of the  $\lambda$ s filter is prohibited.

At  $Rz \le 2 \mu m$  the stylus tip radius is 2  $\mu m$ , at  $Rz > 2 \mu m$  it is 5  $\mu m$ . The distance between two measuring points is  $\le 0.5 \mu m$ .

The cone angle is either 60° or 90°. If not otherwise specified, it is 90°.

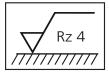
## Drawing entries according to ISO 1302:2002



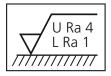
#### Specifications for requirements

a surface parameter with numeric value in µm b second requirement (surface parameter in µm) c production method d specification of valley direction

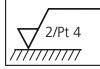
- e machining allowance in mm



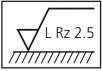
Material removing machining;  $Rz = max. 4 \mu m$ 



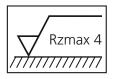
Material removing machining; upper and lower limit value for Ra demanded: Ra = min. 1 µm and max. 4 µm



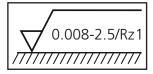
Material removing machining; P-profile, traverse length = 2 mm;  $Pt = max. 4 \mu m$ 



Material removing machining; lower limit value for Rz demanded: Rz = min. 2.5 µm



Material removing machining;  $Rz = max. 4 \mu m$ : the maximum value rule applies



Material removing machining; transmission characteristic does not comply with standard case (cf. table) Rz = max. 1  $\mu$ m; filter selection  $\lambda$ s = 0.008 mm and  $\lambda c = 2.5 \text{ mm}$ 

# Drawing entries according to VDA 2007 – dominant waviness

Case 1: No dominant waviness allowed

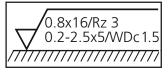
Material removing machining; WDc 0 or WDt 0: no dominant waviness allowed

# Case 2: Dominant wavinesses are allowed up to an upper limit

2.5x5/WDt 2.5 11111111111

Material removing machining; in the period range up to 2.5 mm, WDt = max. 2.5  $\mu$ m applies

Case 3: Dominant wavinesses are allowed in a period length with an upper or an upper and lower limit



Material removing machining; Rz: the evaluation length is 12.5 mm and  $\lambda c = 0.8$  mm, Rz = max. 3  $\mu$ m; WDc: in the period range of 0.2 to 2.5 mm, WDc = max. 1.5  $\mu$ m applies